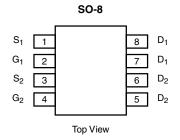




Dual N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
30	0.014 at V _{GS} = 10 V	12.1	5.4 nC		
	0.017 at V _{GS} = 4.5 V	11	5.4 110		



Ordering Information: Si4202DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

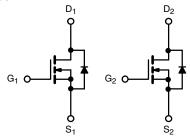
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

COMPLIANT HALOGEN **FREE**

APPLICATIONS

- · Synchronous Buck
 - Notebooks
 - Servers
 - STB



N-Channel MOSFET N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S ($T_A = 25 ^{\circ}C$, unle	ess otherwise no	ted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	_ v	
Gate-Source Voltage		V _{GS}		
	T _C = 25 °C		12.1	
Continuous Proin Current (T. – 150 °C)	T _C = 70 °C		11	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	9.7 ^{a, b}	
	T _A = 70 °C		8.2 ^{a, b}	
Pulsed Drain Current	I _{DM}	50	A	
0 " 0 5 ' 5' 1 0 '	T _C = 25 °C	1	3.1	
Continuous Source Drain Diode Current	T _A = 25 °C	l _S –	2 ^{a, b}	
Avalanche Current	L = 0 1 mH	I _{AS}	15	
Single-Pulse Avalanche Energy	L=UTIIII	E _{AS}	11.25	mJ
	T _C = 25 °C		3.7	
Maximum Davier Dissination	T _C = 70 °C		2.6	\A/
Maximum Power Dissipation	T _A = 25 °C	P _D	2.4 ^{a, b}	W
	T _A = 70 °C		1.7 ^{a, b}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	50	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	33	41	- C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110 °C/W.

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SPECIFICATIONS (T _J = 25 °C			M:	T	Mess	11	
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	V	V 0VI 050A		I	<u> </u>	.,	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		33		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 5.3			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1 μA		
	500	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΛ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 8 \text{ A}$		0.0115	0.0140	Ω	
Diam course on clate Hesistance	· -D3(011)	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$		0.0138	0.0170		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 8 \text{ A}$		33		S	
Dynamic ^b							
Input Capacitance	C _{iss}			710		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		146			
Reverse Transfer Capacitance	C _{rss}			63			
Tatal Cata Chausa	0	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 8 \text{ A}$		11.2	17		
Total Gate Charge	Q _g			5.4	8	200	
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		1.6		nC	
Gate-Drain Charge	Q_{gd}			1.6			
Gate Resistance	R_{g}	f = 1 MHz	0.5	2.5	5	Ω	
Turn-On Delay Time	t _{d(on)}			11	22		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$		18	35		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		14	28		
Fall Time	t _f			8	16		
Turn-On Delay Time	t _{d(on)}			8	16	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		9	18		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		17	34		
Fall Time	t _f			8	16		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			3.1	_	
Pulse Diode Forward Current ^a	I _{SM}				50	Α	
Body Diode Voltage	V _{SD}	I _S = 3 A		0.75	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	-		13	26	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			5.5	11	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °C$		8		-	
, 	a					ns	

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

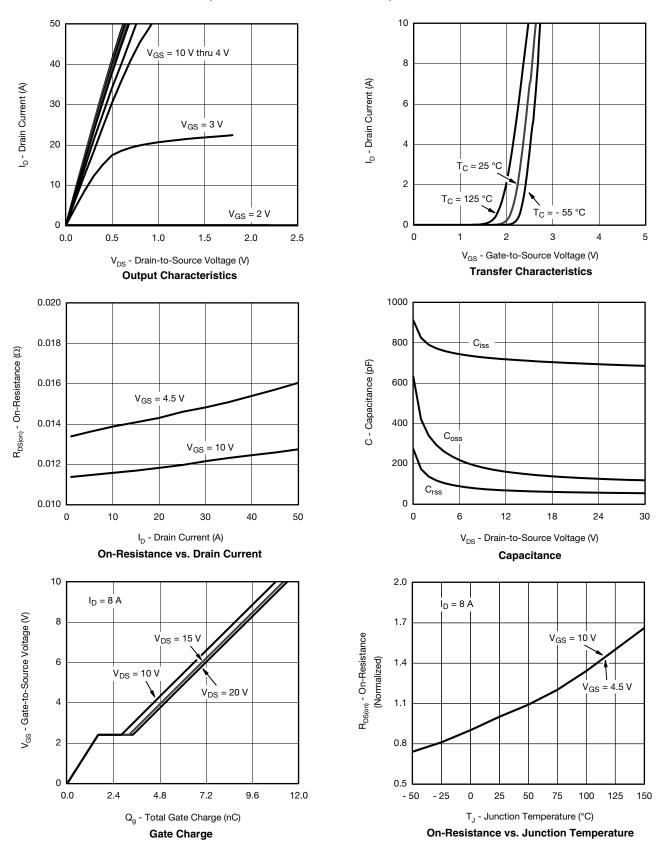
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.



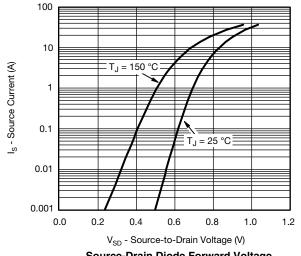


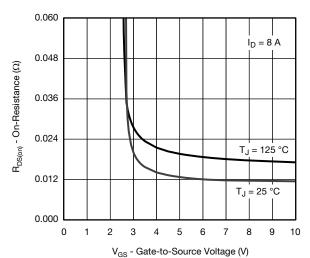
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



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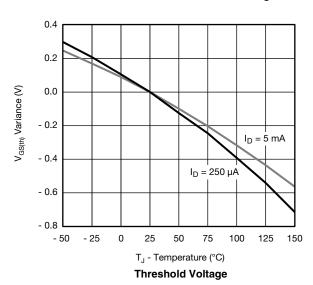
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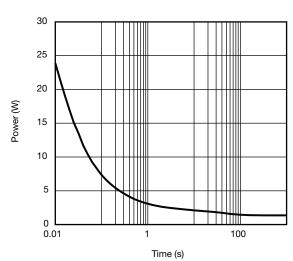




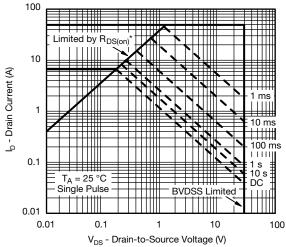
Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage





Single Pulse Power, Junction-to-Ambient

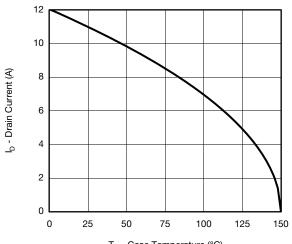


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area

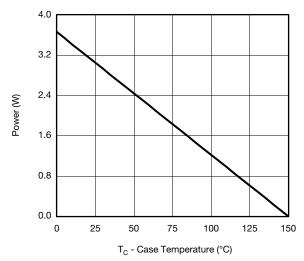


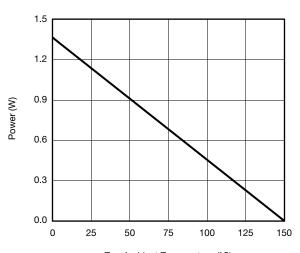
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



 $\rm T_{\rm C}$ - Case Temperature (°C)

Current Derating*





T_A - Ambient Temperature (°C)

Power, Junction-to-Case

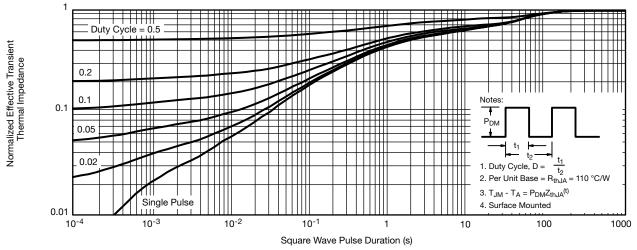
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

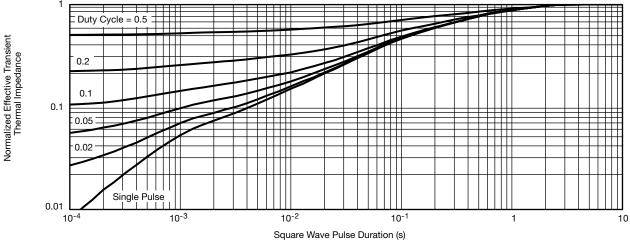
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



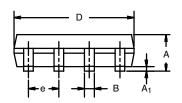
Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?67092.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
FCN: C-06527-Rev 11-Sen-06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06 www.vishay.com



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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